

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	A01			_			
	A02						5.000 52 1000 520
	A03						
	A04						 -
	A05						
	A06						
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	A19						_
	A20						

FOREIGN PATENT DOCUMENTS									
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSL *Abstrac			
						YES	NO		
B01	JP6-87874	12/22/1994	Japan			X			
B02	JP8-111438	4/30/1996	Japan			*X			
B03	JP2002-107408	4/10/2002	Japan		-	*X			
B04			·						
B05									

EXAMINER	DATE CONSIDERED
*EXAMINER: Initial if reference considered, whether or not citation is in conformar	nce with MPEP 609: Draw line through citation if not in conformance and not

considered. Include copy of this form with next communication to applicant.